Application/Control No. Applicant(s)/Patent Under Reexamination 09/845,724 CUI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 David M. Naff 1651 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,331,312 12-2001 424/426 Lee et al. Α В US-US-С D US-US-Ε US-F G US-Н US-US-1 US-J US-K L US-US-М FOREIGN PATENT DOCUMENTS Date Document Number Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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